ASYMMETRIC COMPARATOR FOR LOW POWER APPLICATIONS

Abstract of the Disclosure

A method and structure for comparing an input signal to a reference signal using a comparator comprises a circuit for setting a trip point of a rising edge of an input signal according to a value of an external voltage reference; and at least two transistors, in the circuit, for setting a trip point of a falling edge of an input signal, according to a width-to-length ratio of the at least two transistors. Moreover, the at least two transistors comprises a first transistor of length (Lx) and a width of (W $_{\rm X}$); and a second transistor of length (L $_{\rm Y}$) and a width of (W $_{\rm Y}$), wherein the width-to-length ratio equals (W $_{\rm X}$ L $_{\rm Y}$)/(W $_{\rm Y}$ L $_{\rm X}$). The trip point of a falling edge of an input signal increases (decreases) by increasing (decreasing) the width-to-length ratio.